Metromest

Intelligent Metrology for a sustainable and efficient digital factory

ONLINE EDITION



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Intelligent Metrology for a sustainable and efficient digital factory

09:00 - 09:15	OPENING	Jesús de la Maza
09:15 - 10:00	TUTORIAL	New forms of Digital Metrology for the new intelligent Industry / Toni Ventura-Traveset - Datapixel (Spaln)
10:00 - 10:30	TALK	Extending the measurement capabilities of 3D X-ray microscopes to dimensional metrology Herminso Villarraga-Góme - Zeiss (Spaln)
10:30 - 11:00	ТАЦК	Large volume metrology and portable photogrammetry / Pablo Puerto - Ideko & PTB (Germany)
11:00 - 11:15	BREAK · -	
11:15 - 11:45	TALK	Advanced Metrology for machine tool measurement / Ainhoa Etxabarria - Innovalia Metrology (Spain)
11:45 - 12:15	TALK	Development of innovative smart 4.0 tooling set for the manufacturing and assembly of the Advanced Rear ed product Gorka Kortaberria - Tekniker (Spain)
12:15 - 12:45	TALK	The experience of using material standards and interference systems for checking and calibrating coordinate measuring machines (CMM) of various measurement ranges / Valery Lysenko - VNIIMS (Russia)
12:45 - 15:50	BREAK · -	
15:50 - 16:00	RECONNECT	\bullet
16:00 - 16:45	TUTORIAL	QIF as an ISO standard for the automated Industry / Jennifer Herron - DMSC (USA)
16:45 - 17:15	TALK	5GROWTH: 5G Metrology for a 5G Industry / Oscar Lazaro - Innovalia Association (Spain)
17:15 - 17:45	ROUND TAB	
17:45 - 18:00	CLOSING	Jesús de la Maza
PACKAGE	5	Access 1 person Access 5 people Access 10 people DISCOL
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